

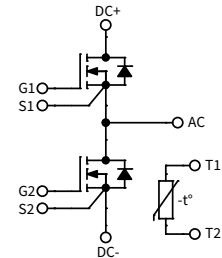
# CAB006A12GM4, CAB006A12GM4T

1200 V, 6 mΩ, Silicon Carbide, Half-Bridge Module

$V_{DS}$	<b>1200 V</b>
$R_{DS(on)}$	<b>6 mΩ</b>

## Technical Features

- Ultra-Low Loss, High Frequency Operation
- Zero Turn-Off Tail Current from MOSFET
- Normally-Off, Fail-Safe Device Operation
- Optional Pre-Applied Thermal Interface Material
- Aluminium Nitride Substrate



## Typical Applications

- DC Fast Chargers
- Energy Storage Systems
- High-Efficiency Converters / Inverters
- Renewable Energy
- Smart-Grid / Grid-Tied Distributed Generation

## System Benefits

- Enables Compact, Lightweight Systems
- Increased System Efficiency due to Low Switching & Conduction Losses of SiC
- Reduced Thermal Requirements and System Cost

## Maximum Parameters (Verified by Design)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions	Note
Drain-Source Voltage	$V_{DS}$			1200	V		
Gate-Source Voltage, Maximum Value	$V_{GS(max)}$	-10		23		Transient	Note 1
Gate-Source Voltage, Recommended	$V_{GS(op)}$		-4/+15			Static	Fig. 33
DC Continuous Drain Current	$I_D$			200	A	$V_{GS} = 15 \text{ V}, T_{HS} = 75 \text{ }^\circ\text{C}, T_{VJ} \leq 150 \text{ }^\circ\text{C}$	Notes 2, 3 Fig. 20
				200		$V_{GS} = 15 \text{ V}, T_{HS} = 75 \text{ }^\circ\text{C}, T_{VJ} \leq 175 \text{ }^\circ\text{C}$	
DC Source-Drain Current (Body Diode)	$I_{SD(BD)}$		140			$V_{GS} = -4 \text{ V}, T_{HS} = 25 \text{ }^\circ\text{C}, T_{VJ} \leq 175 \text{ }^\circ\text{C}$	
Pulsed Drain-Source Current	$I_{DM}$			800		$t_{Pmax}$ limited by $T_{VJmax}$ $V_{GS} = 15 \text{ V}, T_{HS} = 25 \text{ }^\circ\text{C}$	
Power Dissipation	$P_D$		680		W	$T_{HS} = 75 \text{ }^\circ\text{C}, T_{VJ} \leq 175 \text{ }^\circ\text{C}$	Note 4 Fig. 20
Virtual Junction Temperature	$T_{VJ(op)}$	-40		150	°C	Operation	
		-40		175		Intermittent with Reduced Life	

Note (1): Recommended turn-on gate voltage is 15 V with  $\pm 5\%$  regulation tolerance

Note (2): Current limit calculated by  $I_{D(max)} = \sqrt{(P_D / R_{DS(typ)} (T_{VJ(max)} - T_{D(max)}))}$

Note (3): Verified by design

Note (4):  $P_D = (T_{VJ} - T_C) / R_{TH(JC,typ)}$



### MOSFET Characteristics (Per Position) ( $T_{VJ} = 25\text{ }^{\circ}\text{C}$ Unless Otherwise Specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions	Note
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	1200				$V_{GS} = 0\text{ V}, T_{VJ} = -40\text{ }^{\circ}\text{C}$	
Gate Threshold Voltage	$V_{GS(th)}$	1.8	2.5	4.0	V	$V_{DS} = V_{GS}, I_D = 56\text{ mA}$	
			2.0			$V_{DS} = V_{GS}, I_D = 56\text{ mA}, T_{VJ} = 175\text{ }^{\circ}\text{C}$	
Zero Gate Voltage Drain Current	$I_{DSS}$		6	600	$\mu\text{A}$	$V_{GS} = 0\text{ V}, V_{DS} = 1200\text{ V}$	
Gate-Source Leakage Current	$I_{GSS}$		120	2400	nA	$V_{GS} = 19\text{ V}, V_{DS} = 0\text{ V}$	
Drain-Source On-State Resistance (Devices Only)	$R_{DS(on)}$		5.5	6.9	m $\Omega$	$V_{GS} = 15\text{ V}, I_D = 180\text{ A}$	Fig. 2 Fig. 3
			8.4			$V_{GS} = 15\text{ V}, I_D = 180\text{ A}, T_{VJ} = 150\text{ }^{\circ}\text{C}$	
			9.8			$V_{GS} = 15\text{ V}, I_D = 180\text{ A}, T_{VJ} = 175\text{ }^{\circ}\text{C}$	
Transconductance	$g_{fs}$		126		S	$V_{DS} = 20\text{ V}, I_{DS} = 180\text{ A}$	Fig. 4
			124			$V_{DS} = 20\text{ V}, I_{DS} = 180\text{ A}, T_{VJ} = 175\text{ }^{\circ}\text{C}$	
Turn-On Switching Energy, $T_{VJ} = 25\text{ }^{\circ}\text{C}$ $T_{VJ} = 125\text{ }^{\circ}\text{C}$ $T_{VJ} = 175\text{ }^{\circ}\text{C}$	$E_{ON}$		2.1 2.09 2.06		mJ	$V_{DS} = 600\text{ V},$ $I_D = 200\text{ A},$ $V_{GS} = -4\text{ V}/15\text{ V},$ $R_{G(OFF)} = 1\text{ }\Omega,$ $R_{G(ON)} = 1\text{ }\Omega,$ $L_{\sigma} = 10.9\text{ nH}$	Fig. 11 Fig. 13
Turn-Off Switching Energy, $T_{VJ} = 25\text{ }^{\circ}\text{C}$ $T_{VJ} = 125\text{ }^{\circ}\text{C}$ $T_{VJ} = 175\text{ }^{\circ}\text{C}$	$E_{OFF}$		1.3 1.3 1.3				
Internal Gate Resistance	$R_{G(int)}$		0.7		$\Omega$	$f = 100\text{ kHz}$	
Input Capacitance	$C_{iss}$		19.8		nF	$V_{GS} = 0\text{ V}, V_{DS} = 800\text{ V},$ $V_{AC} = 25\text{ mV}, f = 100\text{ kHz}$	Fig. 9
Output Capacitance	$C_{oss}$		0.77				
Reverse Transfer Capacitance	$C_{rss}$		62				
Gate to Source Charge	$Q_{GS}$		738		nC	$V_{DS} = 800\text{ V}, V_{GS} = -4\text{ V}/15\text{ V}$ $I_D = 180\text{ A}$ Per IEC60747-8-4 pg 21	
Gate to Drain Charge	$Q_{GD}$		120				
Total Gate Charge	$Q_G$		858				
FET Thermal Resistance, Junction to Heatsink	$R_{thJHS}$		0.147		$^{\circ}\text{C}/\text{W}$	Measured with Pre-Applied TIM	Fig. 17

### Diode Characteristics (Per Position) ( $T_{VJ} = 25\text{ }^{\circ}\text{C}$ Unless Otherwise Specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions	Note
Body Diode Forward Voltage	$V_{SD}$		5.4		V	$V_{GS} = -4\text{ V}, I_{SD} = 180\text{ A}$	Fig. 7
			4.8			$V_{GS} = -4\text{ V}, I_{SD} = 180\text{ A}, T_{VJ} = 175\text{ }^{\circ}\text{C}$	
Reverse Recovery Time	$t_{RR}$		28.5		ns	$V_{GS} = -4\text{ V}, I_{SD} = 200\text{ A}, V_R = 600\text{ V}$ $di/dt = 22.5\text{ A/ns}, T_{VJ} = 175\text{ }^{\circ}\text{C}$	Fig. 32
Reverse Recovery Charge	$Q_{RR}$		5.4		$\mu\text{C}$		
Peak Reverse Recovery Current	$I_{RRM}$		310		A		
Reverse Recovery Energy $T_{VJ} = 25\text{ }^{\circ}\text{C}$ $T_{VJ} = 125\text{ }^{\circ}\text{C}$ $T_{VJ} = 175\text{ }^{\circ}\text{C}$	$E_{RR}$		0.8 0.95 2.4		mJ	$V_{DS} = 600\text{ V}, I_D = 200\text{ A},$ $V_{GS} = -4\text{ V}/15\text{ V}, R_{G(ON)} = 1\text{ }\Omega,$ $L_{\sigma} = 10.9\text{ nH}$	Fig. 14

## Module Physical Characteristics

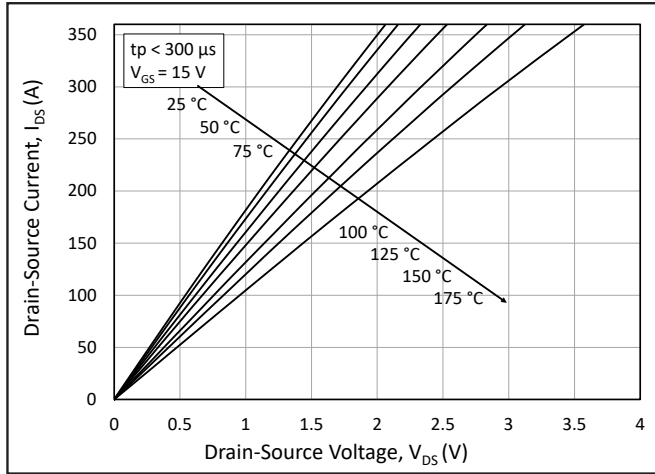
Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Package Resistance, M1 (High-Side)	$R_{pkg1}$		1.40		mΩ	$T_{HS} = 125\text{ °C}$ , Note 5
Package Resistance, M2 (Low-Side)	$R_{pkg2}$		1.10			
Stray Inductance	$L_{Stray}$		5.90		nH	Between DC+ and DC-, $f = 10\text{ MHz}$
Case Temperature	$T_C$	-40		125	°C	
Weight	W		39		g	
Mounting Torque	$M_S$		2.0	2.3	N-m	M4 bolts
Case Isolation Voltage	$V_{isol}$	3			kV	AC, 50 Hz, 1 min
Comparative Tracking Index	CTI	200				
Clearance Distance			5.0		mm	Terminal to Terminal
			10.0			Terminal to Heatsink
Creepage Distance			6.3			Terminal to Terminal
			11.5			Terminal to Heatsink

Note (5): Total Effective Resistance (Per Switch Position) = MOSFET  $R_{DS(on)}$  + Switch Position Package Resistance

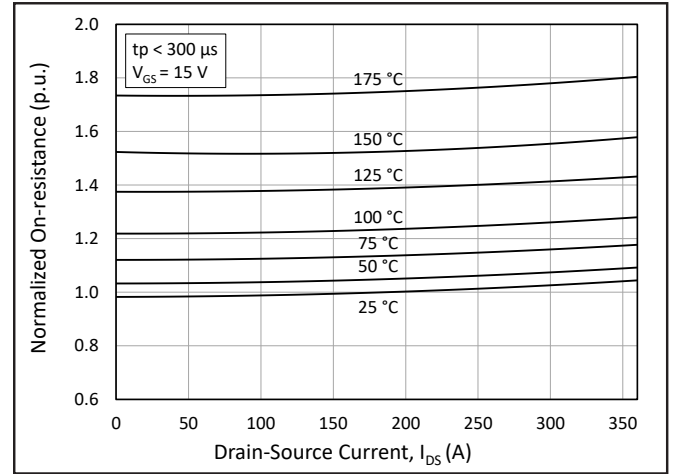
## Temperature Sensor (NTC) Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Rated Resistance	$R_{NTC}$		5.0		kΩ	$T_{NTC} = 25\text{ °C}$
Resistance Tolerance at 25 °C	$\Delta R/R$	-5		5	%	
Beta Value ( $T_2 = 50\text{ °C}$ )	$\beta_{25/50}$		3380		K	
Beta Value ( $T_2 = 80\text{ °C}$ )	$\beta_{25/80}$		3468		K	
Beta Value ( $T_2 = 100\text{ °C}$ )	$\beta_{25/100}$		3523		K	
Power Dissipation	$P_{Max}$			10	mW	$T_{NTC} = 25\text{ °C}$

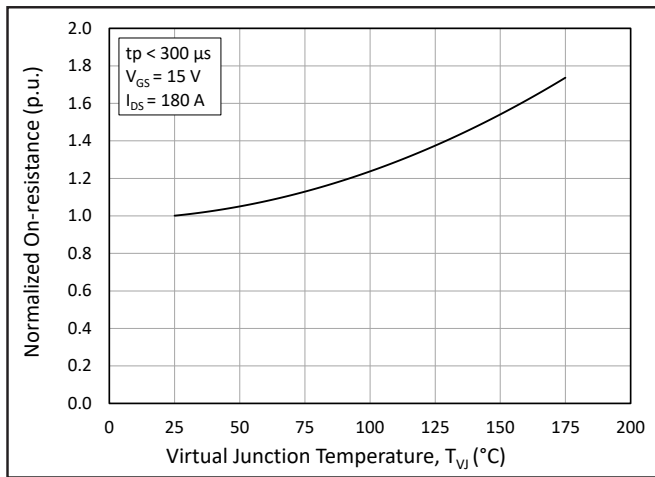
## Typical Performance



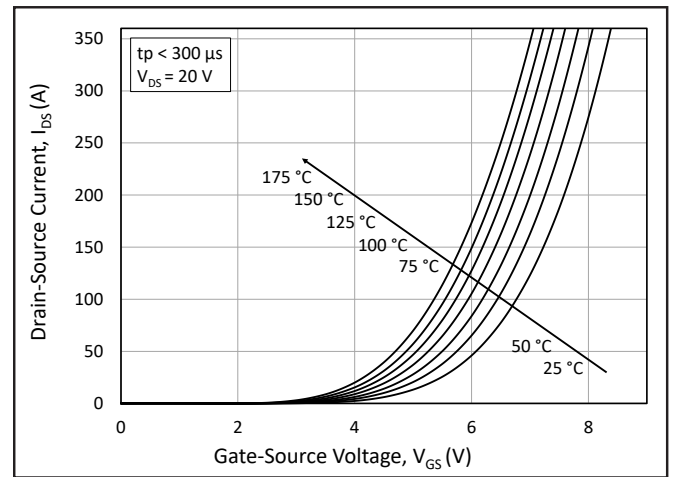
**Figure 1.** Output Characteristics for Various Junction Temperatures



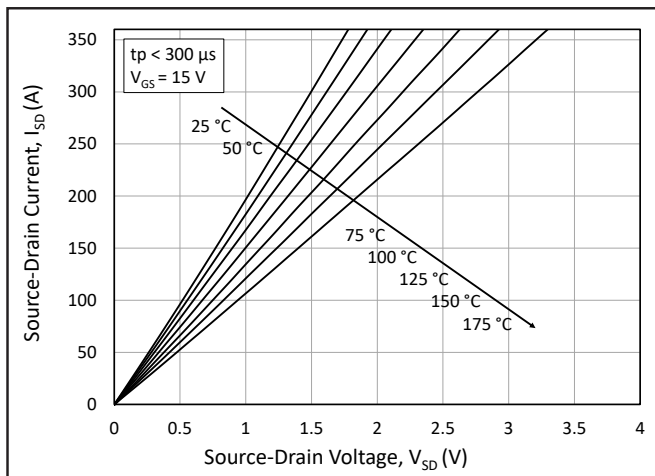
**Figure 2.** Normalized On-State Resistance vs. Drain Current for Various Junction Temperatures



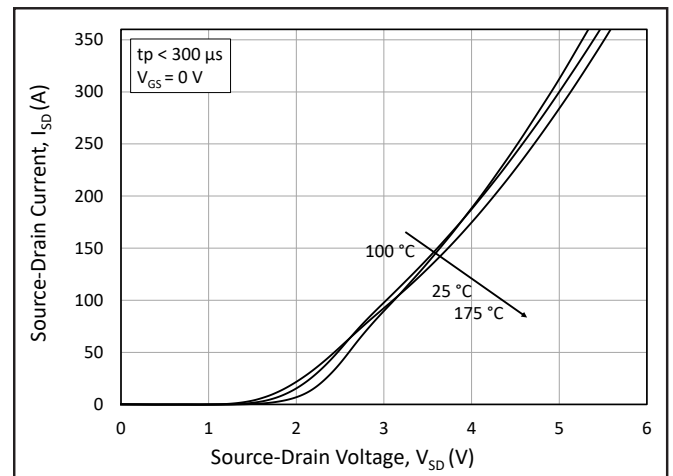
**Figure 3.** Normalized On-State Resistance vs. Junction Temperature



**Figure 4.** Transfer Characteristic for Various Junction Temperatures



**Figure 5.** 3<sup>rd</sup> Quadrant Characteristic vs. Junction Temperatures at  $V_{GS} = 15\text{ V}$



**Figure 6.** 3<sup>rd</sup> Quadrant Characteristic vs. Junction Temperatures at  $V_{GS} = 0\text{ V}$  (Body Diode)



Typical Performance

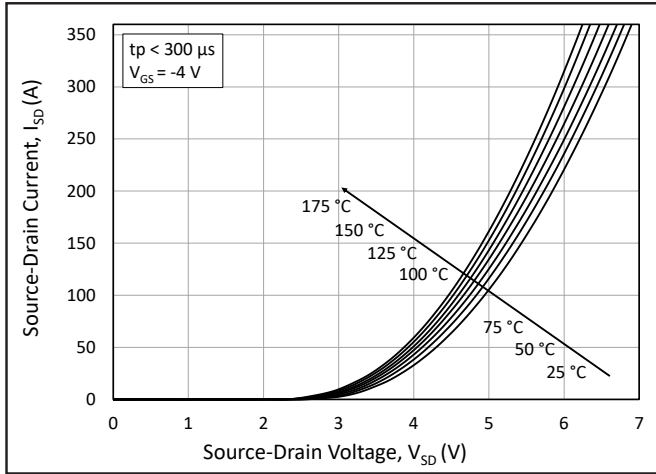


Figure 7. 3<sup>rd</sup> Quadrant Characteristic vs. Junction Temperatures at  $V_{GS} = -4$  V (Body Diode)

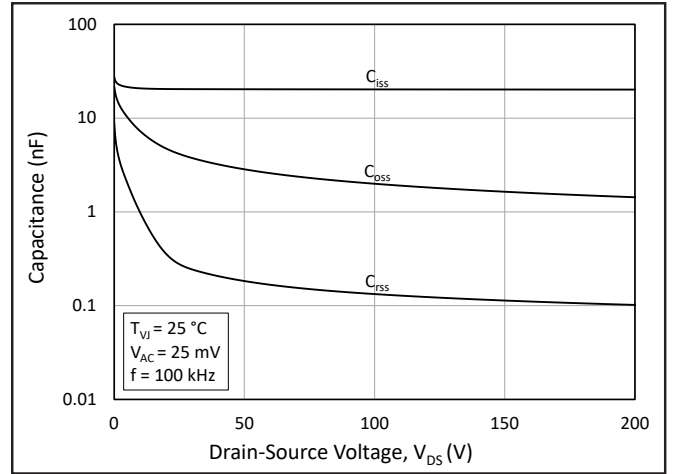


Figure 8. Typical Capacitances vs. Drain to Source Voltage (0 - 200 V)

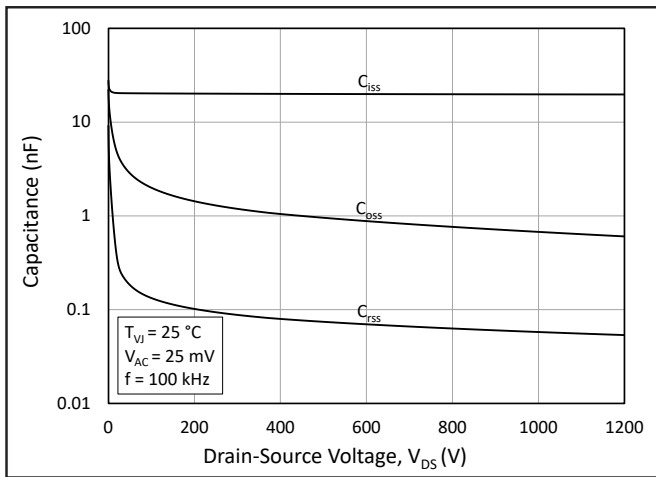


Figure 9. Typical Capacitances vs. Drain to Source Voltage (0 - 1200V)

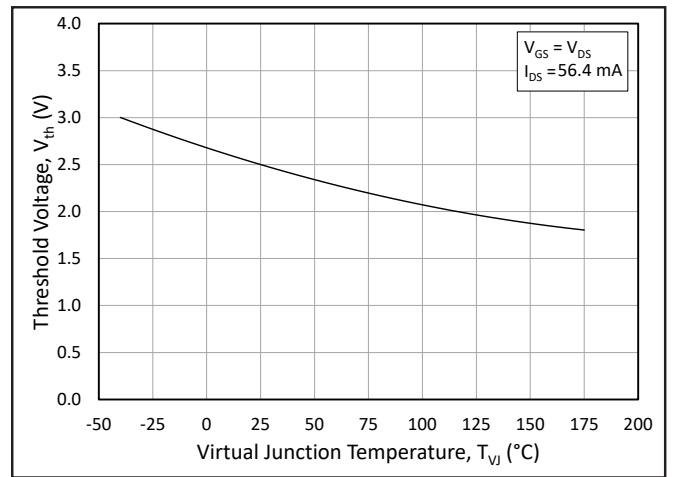


Figure 10. Threshold Voltage vs. Junction Temperature

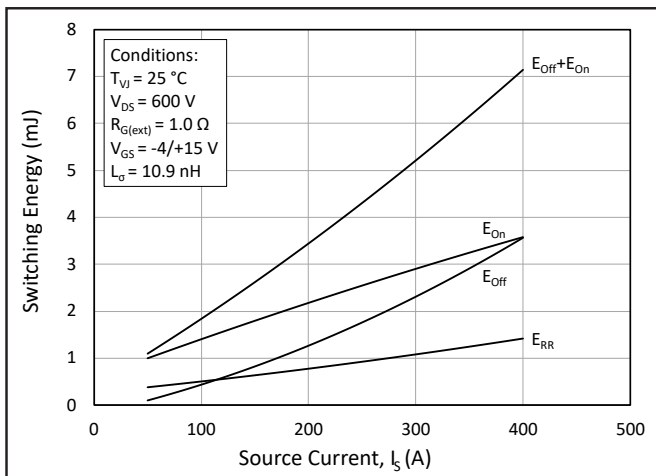


Figure 11. Switching Energy vs. Drain Current ( $V_{DS} = 600$  V)

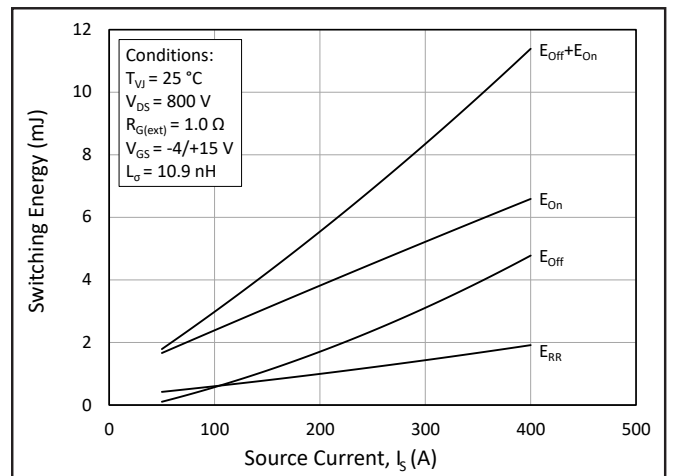


Figure 12. Switching Energy vs. Drain Current ( $V_{DS} = 800$  V)



Typical Performance

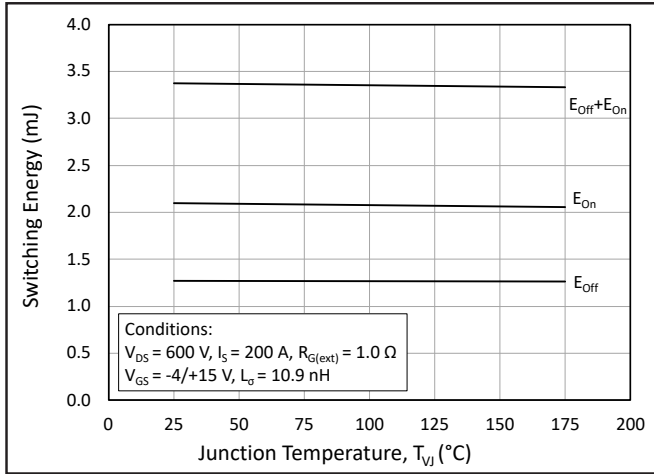


Figure 13. MOSFET Switching Energy vs. Junction Temperature

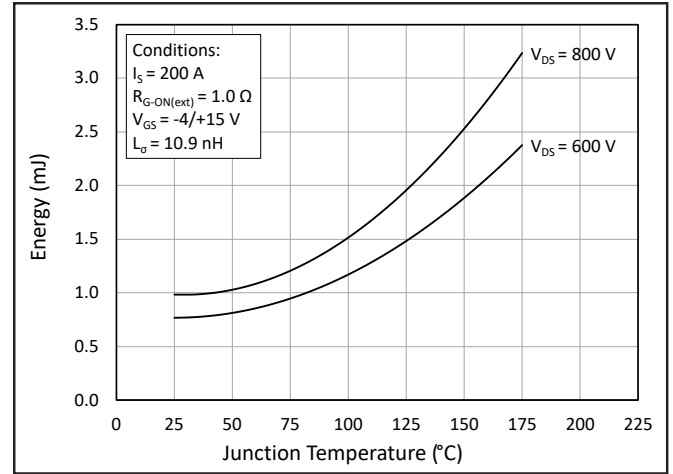


Figure 14. Reverse Recovery Energy vs. Junction Temperature

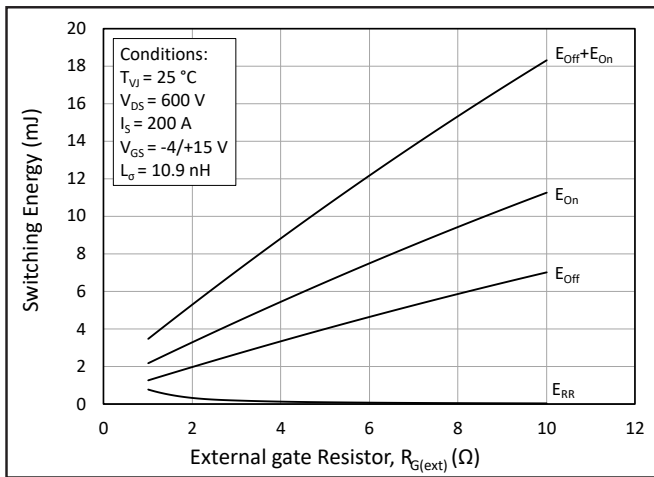


Figure 15. MOSFET Switching Energy vs. External Gate Resistance

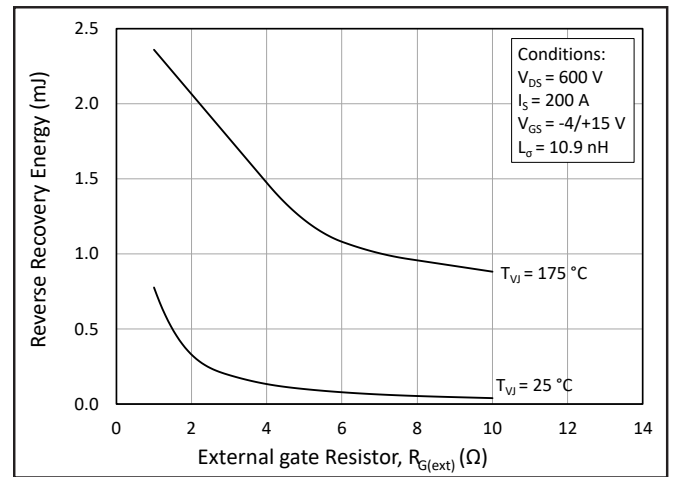


Figure 16. Reverse Recovery Energy vs. External Gate Resistance

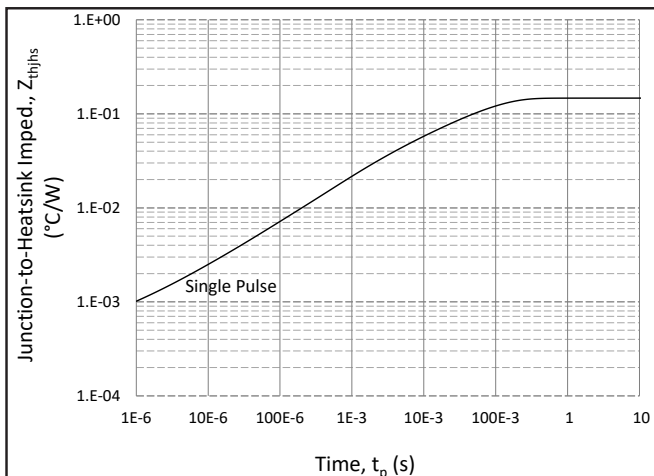


Figure 17. MOSFET Junction to Heatsink Transient Thermal Impedance,  $Z_{thHS}$  (°C/W)

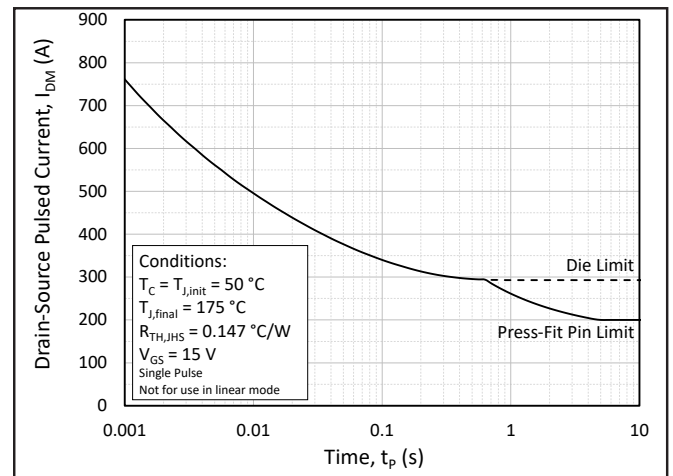


Figure 18. Pulsed Current SOA



Typical Performance

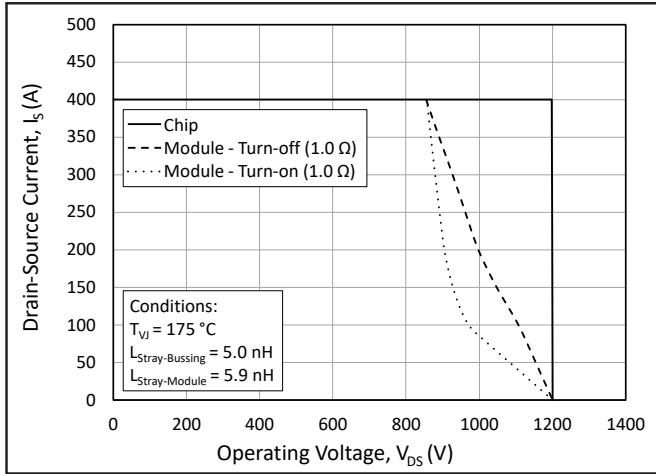


Figure 19. Switching Safe Operating Area

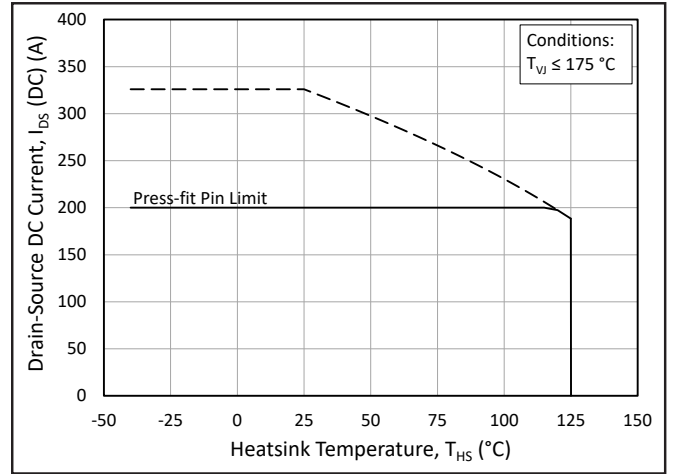


Figure 20. Continuous Drain Current Derating vs. Heatsink Temperature

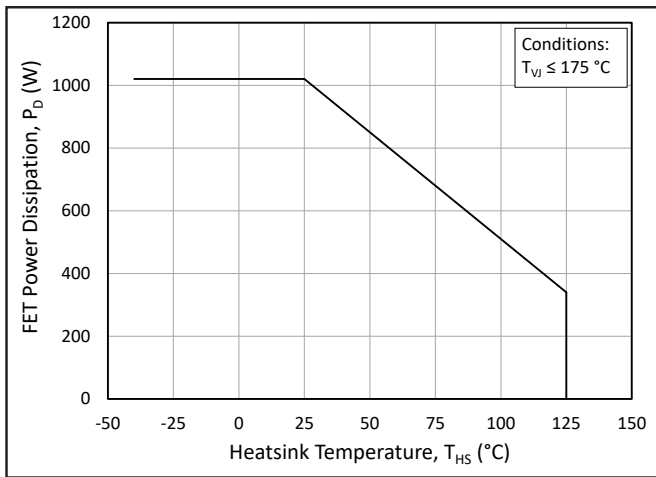


Figure 21. Maximum Power Dissipation Derating vs. Heatsink Temperature

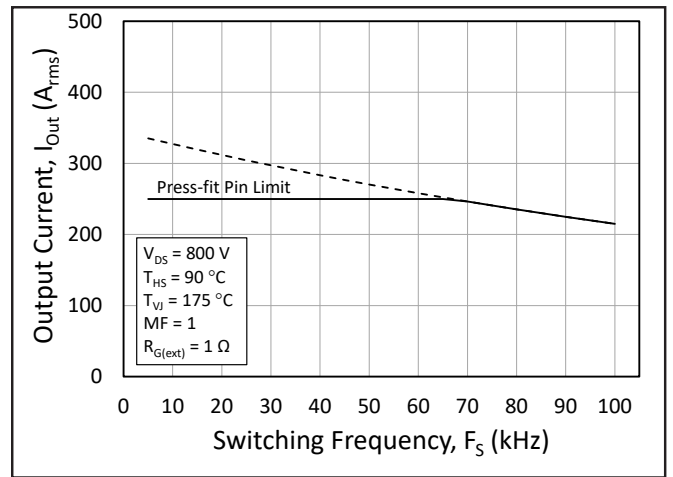


Figure 22. Typical Output Current Capability vs. Switching Frequency (Inverter Application)

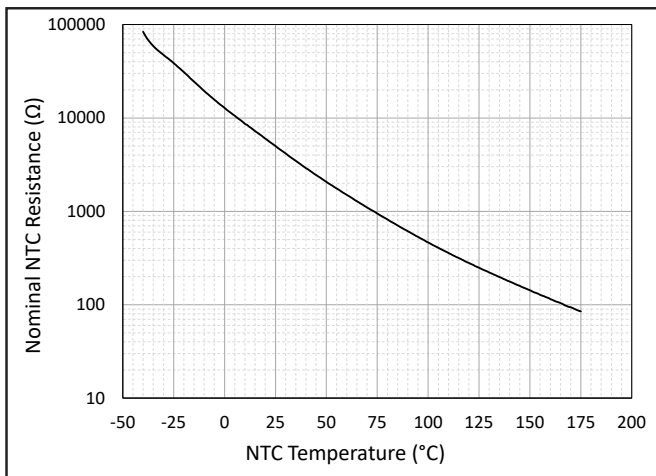
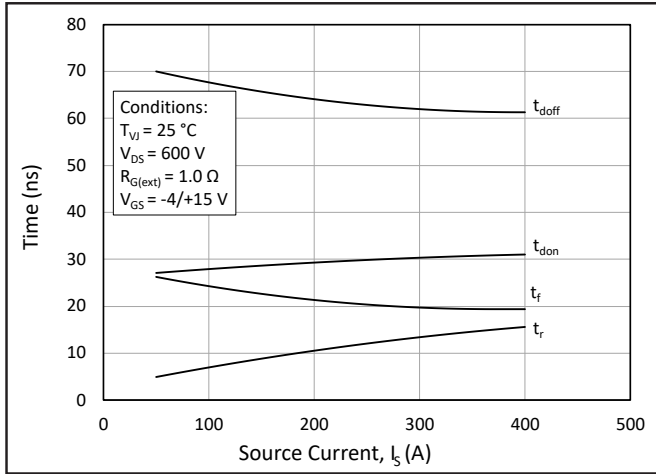
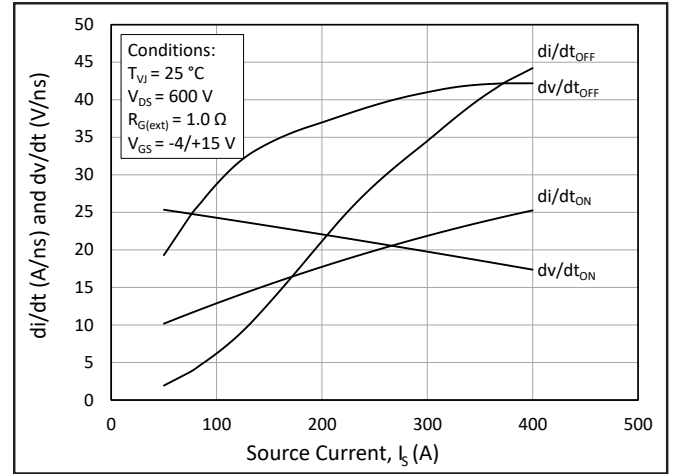


Figure 23. Typical NTC Resistance vs. Temperature

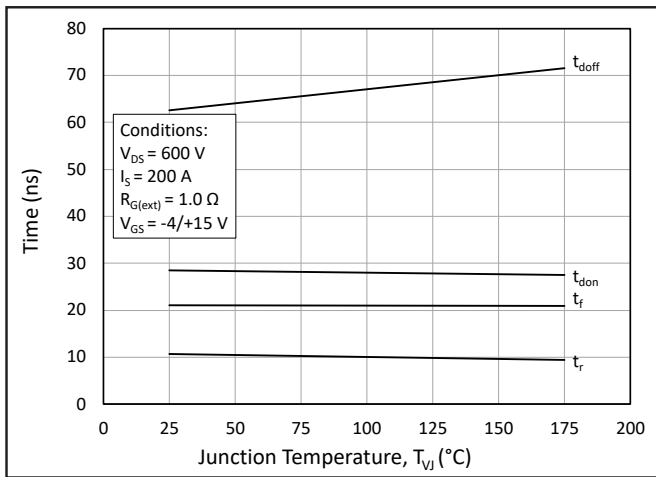
## Timing Characteristics



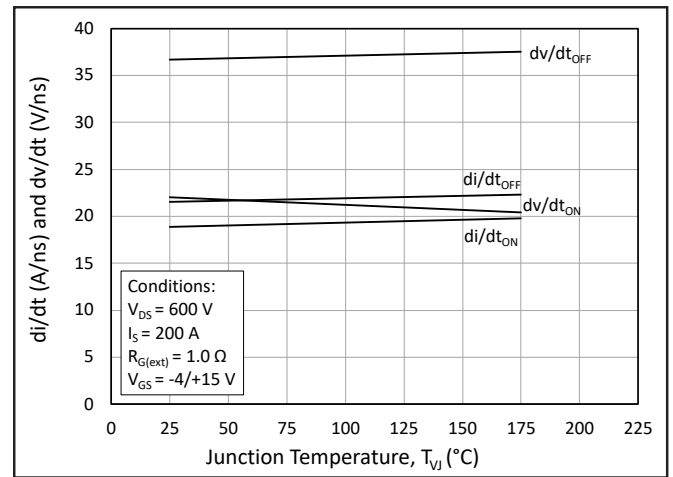
**Figure 24.** Timing vs. Source Current



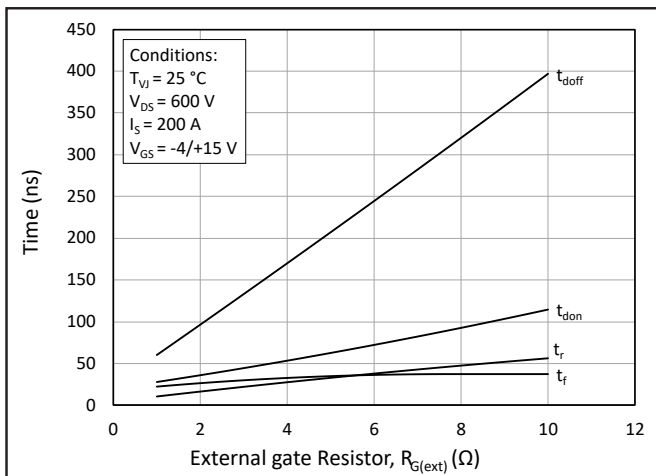
**Figure 25.**  $dv/dt$  and  $di/dt$  vs. Source Current



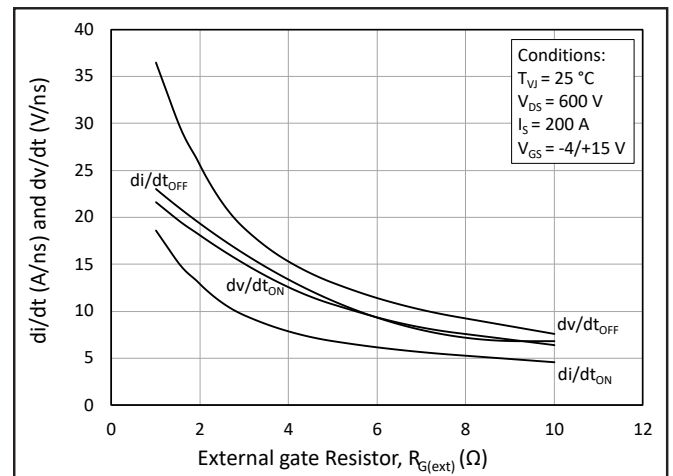
**Figure 26.** Timing vs. Junction Temperature



**Figure 27.**  $dv/dt$  and  $di/dt$  vs. Junction Temperature



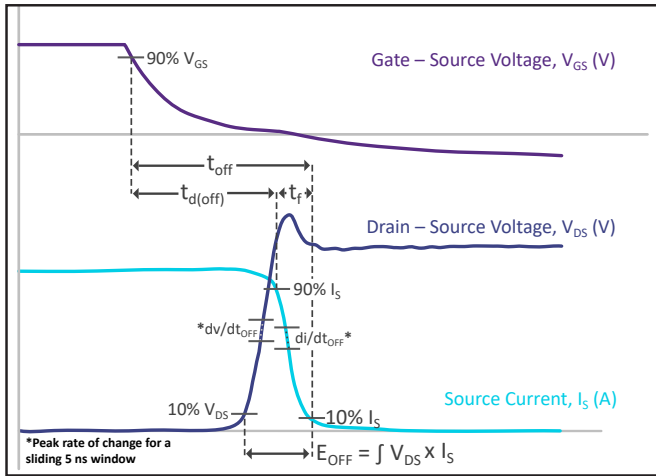
**Figure 28.** Timing vs. External Gate Resistance



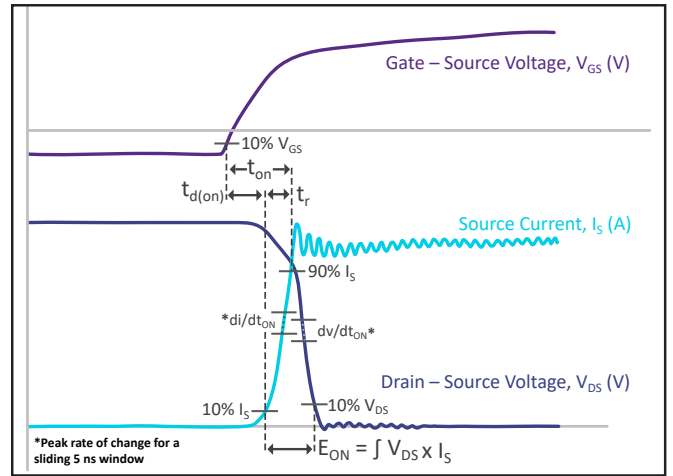
**Figure 29.**  $dv/dt$  and  $di/dt$  vs. External Gate Resistance



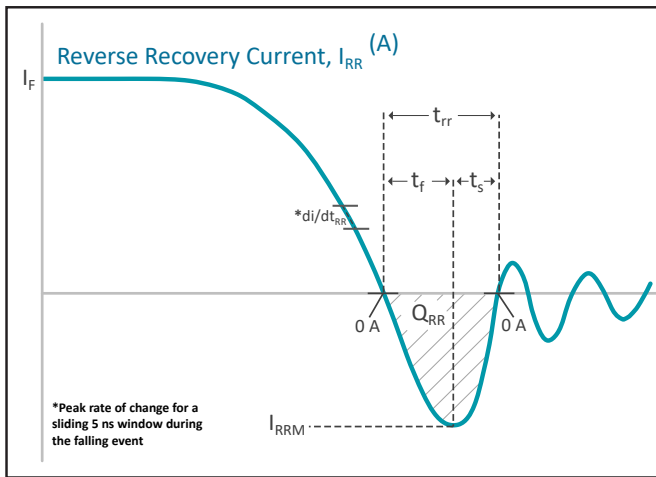
**Definitions**



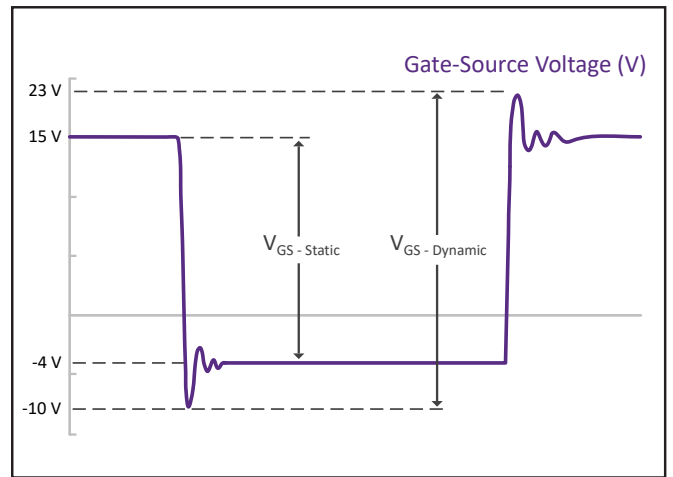
**Figure 30. Turn-Off Transient Definitions**



**Figure 31. Turn-On Transient Definitions**



**Figure 32. Reverse Recovery Definitions**

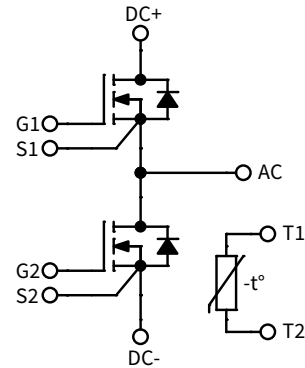
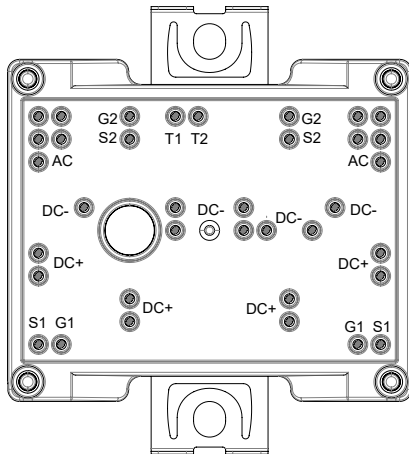


**Figure 33. V<sub>GS</sub> Transient Definitions**

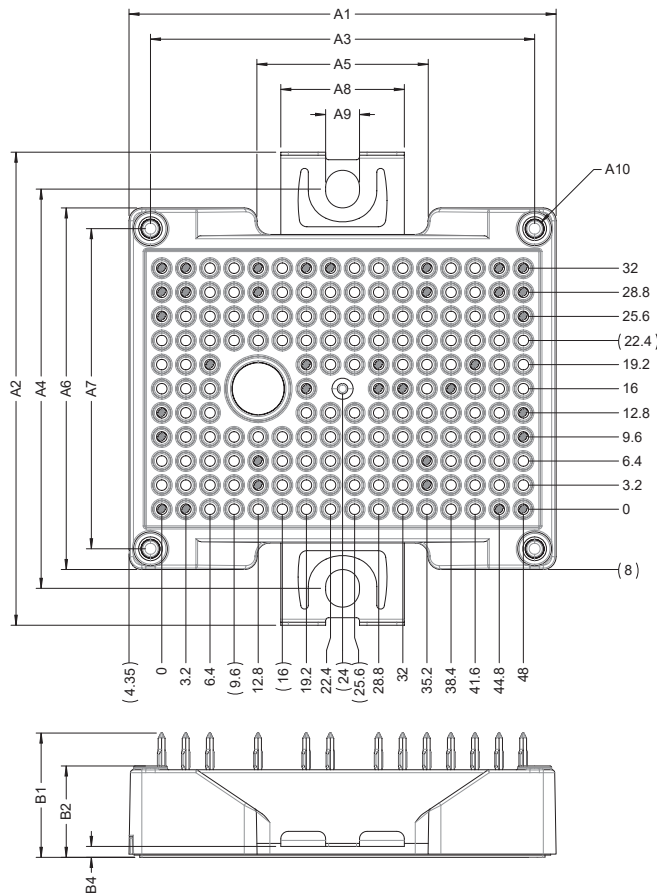
Note (6): A gate driver featuring the IXDD614SI gate driver IC, was used to evaluate dynamic performance. The typical driver high-state output resistance of 0.4 ohms and low-state output resistance of 0.3 ohms are not included in the RG(ext) values on this datasheet.



### Schematic and Pin Out



### Package Dimensions (mm)



DIMENSION TABLE		
SYMBOL	DIMENSION	TOLERANCE
A1	56.7	±0.30
A2	62.8	±0.50
A3	51	±0.15
A4	(53)	REF.
A5	22.7	±0.30
A6	48	±0.30
A7	42.5	±0.15
A8	16.4	±0.20
A9	4.5	±0.10
A10	∅2.3 ∇8.5	∅: +0 -0.10 ∇: ±0.30
B1	16.4	±0.50
B2	12.33	±0.35
B4	1.65	±0.20
ALL PIN LOCATIONS ±0.40		

CAB006A12GM4 has been certified by UL as an “Electrically Isolated Semiconductor Devices – Component” in accordance with UL 1557. Only power modules that bear the UL marking shown should be considered as being covered under the UL Component Recognition Program.





## Product Ordering Code

Part Number	Description
CAB006A12GM4	Without Pre-Applied Phase Change Thermal Interface Material
CAB006A12GM4T	With Pre-Applied Phase Change Thermal Interface Material

## Supporting Links & Tools

### Evaluation Tools & Support

- [SpeedFit 2.0 Design Simulator™](#)
- [Technical Support Forum](#)
- [LTspice and PLECS Models](#)

### Dual-Channel Gate Driver Board

- [CGD12HB00D: Differential Transceiver Daughter Board Companion Tool for Differential Gate Drivers](#)
- [CGD1700HB2M-UNA: Wolfspeed Gate Driver Board](#)
- [EVAL-ADUM4146WHB1Z: Analog Devices® Gate Driver Board](#)
- [UCC21710QDWEVM-054: Texas Instruments® Gate Driver Board](#)

### Application Notes

- [PRD-02302: WolfPACK™ Mounting Instructions and PCB Requirements](#)
- [PRD-04814: Design Options for Wolfspeed® Silicon Carbide MOSFET Gate Bias Power Supplies](#)
- [PRD-06379: Environmental Considerations for Power Electronics Systems](#)
- [PRD-07845: Power Module Baseplate Capacitance and Electromagnetic Compatibility](#)
- [PRD-07933: Wolfspeed Power Module Thermal Interface Material Application User Guide](#)
- [PRD-07968: Wolfspeed WolfPACK™ Dynamic Performance](#)
- [PRD-08333: Wolfspeed Module CIL Evaluation Kits User Guide](#)
- [PRD-08376: Thermal Characterization Methods and Applications](#)
- [PRD-08710: Measuring Stray Inductance in Power Electronics Systems](#)
- [PRD-08911: Considerations for Current Balancing in Paralleled SiC Power Modules](#)
- [PRD-09035: Power Module RC Thermal Models User Guide](#)



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### **REACH Compliance**

REACH substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact your Wolfspeed representative to ensure you get the most up-to-date REACH SVHC Declaration. REACH banned substance information (REACH Article 67) is also available upon request.

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